Search Notes



Application/Control No.

Applicant(s)/Patent Under Reexamination

10508906

ADACHI, TATSUYA

Examiner

Art Unit

Trujillo, James K

2116

SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB), see attached; NPL: IEEE; Inventor Search/DP; Text search in cls 713/300+.	3/21/07	JKT		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

U.S. Patent and Trademark Office Part of Paper No.: 20070321